

<b>Notice of References Cited</b>	Application/Control No. 10/790,061		Applicant(s)/Patent Under Reexamination YUI ET AL.	
	Examiner Tae H. Yoon		Art Unit 1714	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,328,309	06-1967	GRIFO RICHARD A; et. al.	510/417
*	B	US-7,105,477	09-2006	Takiguchi et al.	510/418
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	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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